APT30DQ100BG Datasheet Ultrafast Soft Recovery Rectifier Diode

April 2018





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1 Revision History

The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

1.1 Revision D

Revision D was published in April 2018. The following is a summary of the changes in revision D of this document.

- Product image was updated.
- Product features were updated. For information, see Product Overview (see page 2).
- The lead thickness in the package outline drawing was updated. For more information, see Package Outline Drawing (see page 8).

1.2 Revision C

Revision C was published in May 2011. The following is a summary of the changes in Revision C of this document.

- Patent Information was removed.
- B-Pack Information was updated.
 - Changed max lead thickness from 0.79 (.031) to 1.016 (.040).

1.3 Revision B

Revision B was published in July 2009. The following is a summary of the changes in Revision B of this document.

Graphs were added.

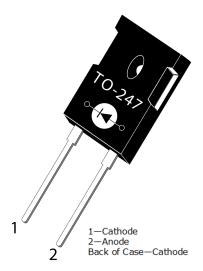
1.4 Revision A

Revision A was published in January 2006. It is the first publication of this document.



2 Product Overview

This section outlines the product overview for the APT30DQ100BG device.



2.1 Features

The following are key features of the APT30DQ100BG device:

- Ultrafast recovery times
- Soft recovery characteristics
- Low forward voltage
- Low leakage current
- Avalanche energy rated
- RoHS compliant
- AEC-Q101 qualified

2.2 Benefits

The following are benefits of the APT30DQ100BG device:

- High switching frequency
- Low switching losses
- Low noise (EMI) switching
- Higher reliability systems
- Increased system power density

2.3 Applications

The APT30DQ100BG device is designed for the following applications:

- Power factor correction (PFC)
- Anti-parallel diode
 - Switch-mode power supply
 - Inverters/converters
 - Motor controllers
- Freewheeling diode
 - Switch-mode power supply
 - Inverters/converters
- Snubber/clamp diode



3 Electrical Specifications

This section details the electrical specifications for the APT30DQ100BG device.

3.1 Absolute Maximum Ratings

The following table shows the maximum ratings for the APT30DQ100BG device.

All ratings: Tc = 25 °C unless otherwise specified.

Table 1 • Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
VR	Maximum DC reverse voltage	1000	V
VRRM	Maximum peak repetitive reverse voltage	1000	_
V _{RWM}	Maximum working peak reverse voltage	1000	_
I _{F(AV)}	Maximum average forward current (Tc = 102 °C, duty cycle = 0.5)	30	Α
I _F (RMS)	RMS forward current	43	_
IFSM	Non-repetitive forward surge current (T _J = 45 °C, 8.3 ms)	150	_
Eavl	Avalanche energy (1 A, 40 mH)	20	mJ
Tı ,Tstg	Operating and storage temperature range	-55 to 175	°C
Tι	Lead temperature for 10 s	300	_

3.2 Electrical Performance

The following table shows the static electrical characteristics of the APT30DQ100BG device.

Table 2 • Static Electrical Characteristics

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	Unit
VF	Forward voltage	I _F = 30 A		2.5	3.0	V
		I _F = 60 A		3.06		_
		I _F = 30 A, T _J = 125 °C		1.92		_
Irm	Maximum reverse	V _R = 1000 V			100	μΑ
	leakage current	V _R = 1000 V, T _J = 125 °C			500	=
Ст	Junction capacitance	V _R = 200 V		26		pF



3.3 Dynamic Characteristics

The following table shows the dynamic characteristics of the APT30DQ100BG device.

Table 3 • Dynamic Characteristics

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	Unit
trr	Reverse recovery time	I _F = 1 A, di _F /dt = -100 A/μs		24		ns
		$V_R = 30 \text{ V}$, $T_J = 25 ^{\circ}\text{C}$				
trr	Reverse recovery time	I _F = 30 A, di _F /dt = -200 A/μs		295		=
Qrr	Reverse recovery charge	- V _R = 667 V, T _C = 25 °C		440		nC
Irrm	Maximum reverse recovery current	=		4		Α
trr	Reverse recovery time	I _F = 30 A, di _F /dt = -200 A/μs		330		ns
Qrr	Reverse recovery charge	- V _R = 667 V, T _C = 125 °C		1550		nC
IRRM	Maximum reverse recovery current	-		8		Α
trr	Reverse recovery time	$I_F = 30 \text{ A, } di_F/dt = -1000 \text{ A/}\mu\text{s}$		150		ns
Qrr	Reverse recovery charge	- V _R = 667 V, T _C = 125 °C		2250		nC
IRRM	Maximum reverse recovery current	-		25		Α

3.4 Thermal and Mechanical Characteristics

This section shows the thermal and mechanical characteristics of the APT30DQ100BG device.

Table 4 • Thermal and Mechanical Characteristics

Symbol	Characteristic/Test Conditions	MIN	TYP	MAX	UNIT
Reuc	Junction-to-case thermal resistance			0.80	°C/W
WT	Package weight		0.22		OZ
			5.9		g
Torque	Maximum mounting torque			10	lb-in
				1.1	N-m

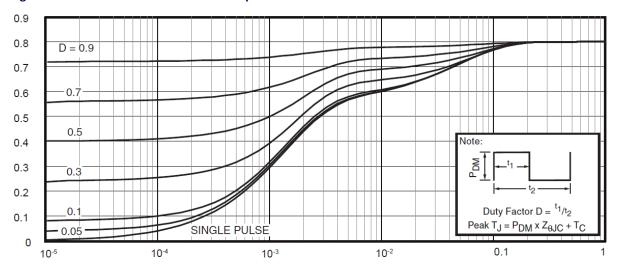
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3.5 Typical Performance Curves

This section shows the typical performance curves for the APT30DQ100BG device.

Figure 1 • Maximum Transient Thermal Impedance



RECTANGULAR PULSE DURATION (seconds)

Figure 2 • Forward Current vs. Forward Voltage

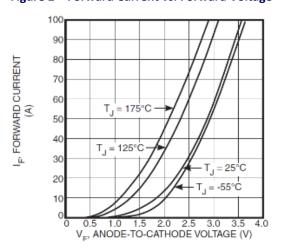


Figure 3 • trr vs. Current Rate of Change

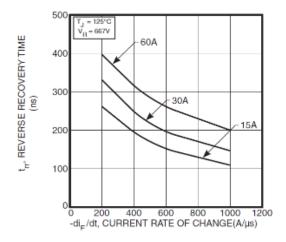




Figure 4 ● Reverse Recovery Charge vs. Current Rate of Change

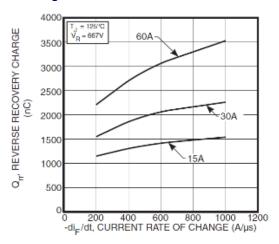


Figure 6 • Dynamic Parameters vs. Junction Temperature

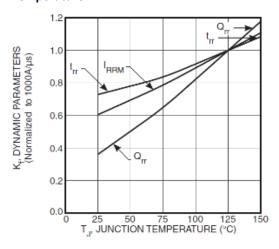


Figure 8 • Junction Capacitance vs. Reverse Voltage

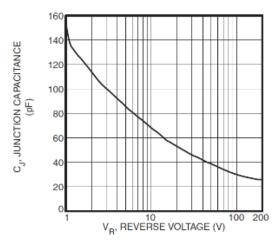


Figure 5 • Reverse Recovery Current vs. Current Rate of Change

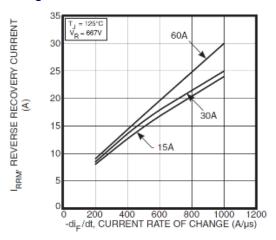
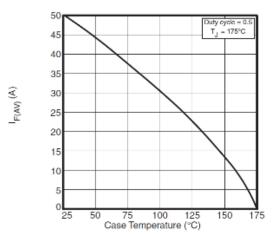


Figure 7 • Maximum Average Forward Current vs. Case Temperature





3.6 Reverse Recovery Overview

The following figures illustrate the reverse recovery testing and measurement information for the APT30DQ100BG device.

Figure 9 • Diode Test Circuit

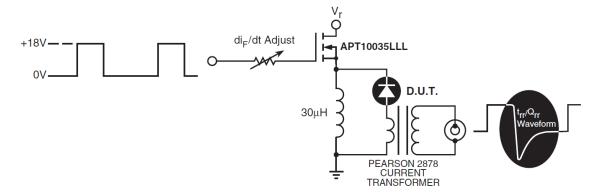
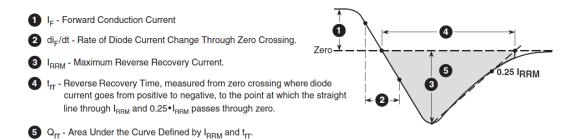


Figure 10 ● Diode Reverse Recovery Waveform and Definitions





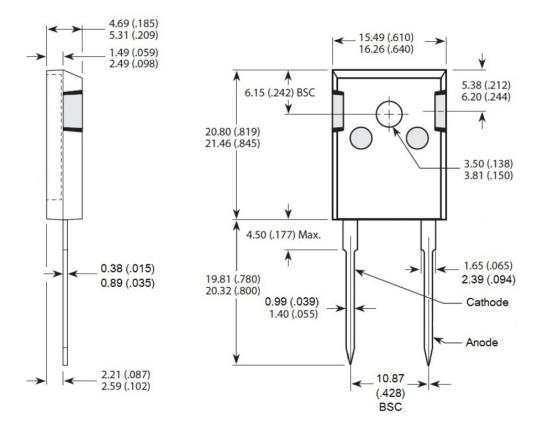
4 Package Specification

This section outlines the package specification for the APT30DQ100BG device.

4.1 Package Outline Drawing

This section details the TO-247 package drawing of the APT30DQ100BG device.

Figure 11 • Package Outline Drawing







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